

Abstract Submitted
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Electron-electron interaction induced effective mass suppression in bilayer graphene JING LI, KE ZOU, ADAM STABILE, DONALD SEIWELL, JUN ZHU, Department of Physics, The Pennsylvania State University — The effective mass of carriers m^* captures fundamental properties of a material. In a two-dimensional electron system, the electron-electron (e-e) interaction manifests in the renormalization of m^* . Extending previous studies[1] to lower carrier densities, where the interaction effect is expected to be stronger, we present precision measurements of the electron and hole effective mass m_e^* and m_h^* in high-quality ($\mu \sim 30,000\text{cm}^2/\text{Vs}$) hexagonal boron nitride supported bilayer graphene using temperature-dependent Shubnikov-de Hass oscillations. Our measurements probe carrier densities down to $2 \times 10^{11}/\text{cm}^2$. Comparison to tight-binding bands and previous data shows excellent agreement at carrier densities above $5 \times 10^{11}/\text{cm}^2$, where m_e^* and m_h^* can be well described by a renormalized Fermi velocity of $v_F = 1.11 \times 10^6\text{m/s}$. At lower carrier densities, m_h^* continuously decreases from the tight-binding band value, reaching $m_h^* = 0.0234m_e$ at $n = 2 \times 10^{11}/\text{cm}^2$. This corresponds to a suppression of 30% and an increased $v_F = 1.37 \times 10^6\text{m/s}$. The deviation is much smaller for electrons. We compare our results with theory and discuss its implications. [1] K. Zou, X. Hong, and J. Zhu, Phys. Rev. B 84, 085408 (2011).

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